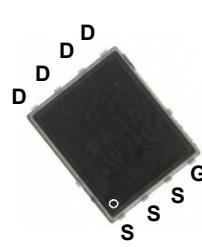
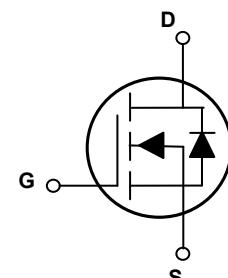


## Main Product Characteristics

$V_{(BR)DSS}$	100V
$R_{DS(ON)}$	19mΩ(max.)
$I_D$	45A



PPAK5x6



Schematic Diagram

## Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



## Description

The GSFP19010 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

## Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage	$V_{DS}$	100	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous, at Steady-State, ( $T_C=25^\circ\text{C}$ ) <sup>1</sup>	$I_D$	45	A
Drain Current-Continuous, at Steady-State, ( $T_C=100^\circ\text{C}$ )		32	
Drain Current-Pulsed <sup>2</sup>	$I_{DM}$	180	A
Single Pulse Avalanche Energy <sup>3</sup>	$E_{AS}$	81	mJ
Power Dissipation ( $T_C=25^\circ\text{C}$ )	$P_D$	60	W
Linear Derating Factor ( $T_C=25^\circ\text{C}$ )		0.48	W/ $^\circ\text{C}$
Junction-to-Ambient (PCB Mounted, Steady-State) <sup>4</sup>	$R_{\theta JA}$	62	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	2.1	$^\circ\text{C}/\text{W}$
Operating Junction Temperature Range	$T_J$	-55 To +150	$^\circ\text{C}$
Storage Temperature Range	$T_{STG}$	-55 To +150	$^\circ\text{C}$

**Electrical Characteristics** ( $T_C=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>On / Off Characteristics</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_D=250\mu\text{A}$	100	-	-	V
Drain-Source Leakage Current	$I_{\text{DSS}}$	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	$\mu\text{A}$
		$T_J=125^\circ\text{C}$	-	-	20	
Gate-Source Forward Leakage	$I_{\text{GSS}}$	$V_{\text{GS}}=\pm20\text{V}$	-	-	$\pm100$	nA
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_D=33\text{A}$	-	15	19	$\text{m}\Omega$
		$V_{\text{GS}}=6\text{V}, I_D=16\text{A}$	-	19	34	
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}}=V_{\text{DS}}, I_D=250\mu\text{A}$	2.1	3.0	3.8	V
<b>Dynamic and Switching Characteristics</b>						
Total Gate Charge	$Q_g$	$V_{\text{DS}}=50\text{V}, I_D=33\text{A}$ $V_{\text{GS}}=10\text{V}$	-	23	-	nC
Gate-Source Charge	$Q_{\text{gs}}$		-	10	-	
Gate-Drain ("Miller") Charge	$Q_{\text{gd}}$		-	4.9	-	
Turn-On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DS}}=50\text{V}, R_{\text{GEN}}=2\Omega$ $V_{\text{GS}}=10\text{V}, I_D=33\text{A}$	-	8.4	-	nS
Rise Time	$t_r$		-	28.5	-	
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	22.4	-	
Fall Time	$t_f$		-	7.8	-	
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=50\text{V}, V_{\text{GS}}=0\text{V}, F=1\text{MHz}$	-	1355	-	pF
Output Capacitance	$C_{\text{oss}}$		-	171	-	
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	4	-	
Gate Threshold Resistance	$R_g$	$F=1\text{MHz}$	-	2.2	-	$\Omega$
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
Continuous Source Current (Body Diode)	$I_s$	MOSFET symbol showing the integral reverse p-n junction diode.	-	-	45	A
Pulsed Source Current (Body Diode)	$I_{\text{SM}}$		-	-	180	A
Diode Forward Voltage	$V_{\text{SD}}$	$V_{\text{GS}}=0\text{V}, I_s=45\text{A}$	-	1.0	1.2	V
Reverse Recovery Time	$T_{\text{rr}}$	$I_F=45\text{A}, T_J=25^\circ\text{C}, \frac{dI}{dt}=100\text{A}/\mu\text{s}$	-	56	-	ns
Reverse Recovery Charge	$Q_{\text{rr}}$		-	0.09	-	$\mu\text{C}$

Note:

1. Pulse test: pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .
2. Repetitive rating: Pulsed width limited by maximum junction temperature.
3.  $L=0.5\text{mH}, V_{\text{DD}}=80\text{V}, I_{\text{AS}}=18\text{A}, R_g=25\Omega, T_J=25^\circ\text{C}$ .
4. Device mounted on FR-4 PCB, 1inch x 0.85inch x 0.062inch.

## Typical Electrical and Thermal Characteristic Curves

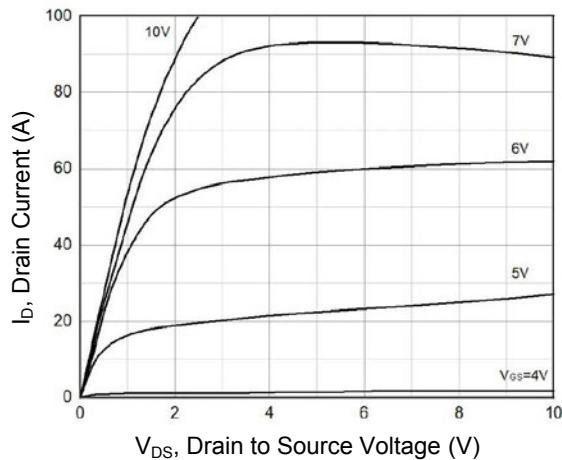


Figure 1. Typical Output Characteristics

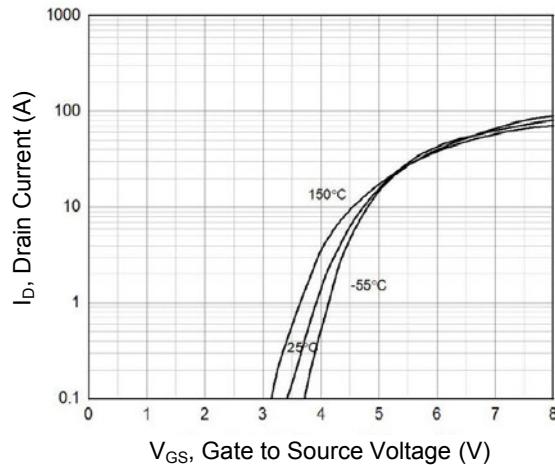


Figure 2. Transfer Characteristics

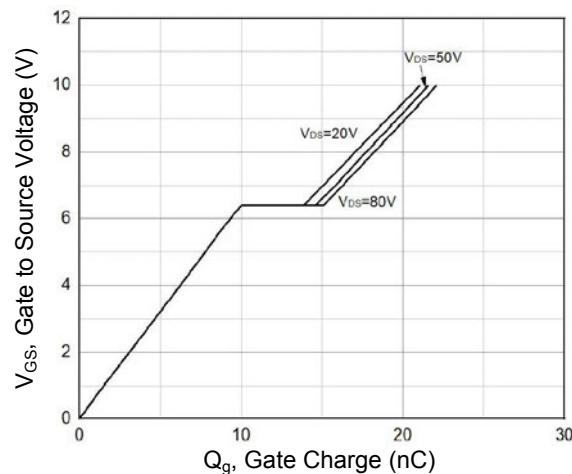


Figure 3. Gate Charge Characteristics

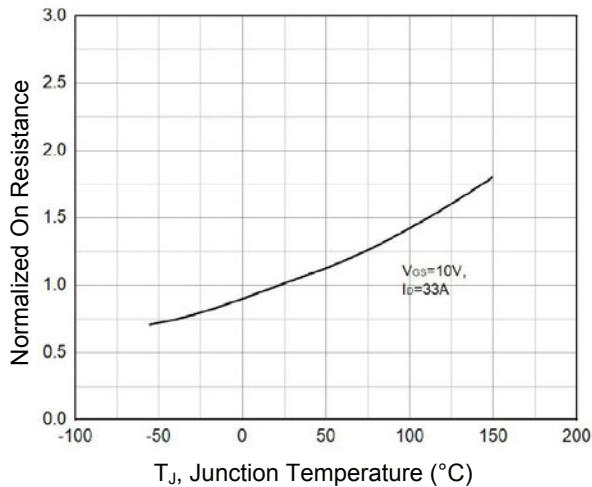


Figure 4. Normalized  $R_{DS(ON)}$  vs. Junction Temperature

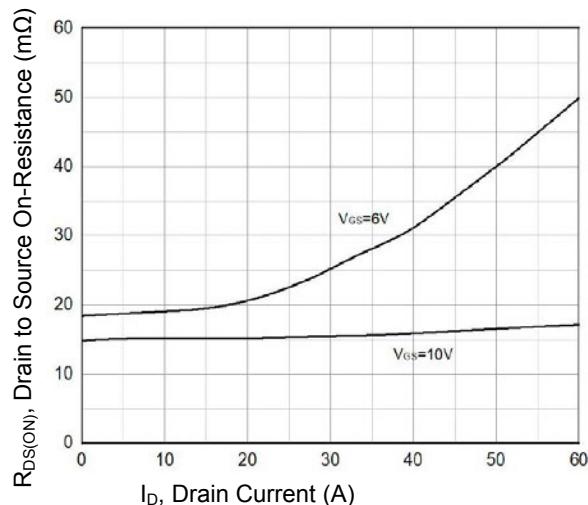


Figure 5. On-Resistance vs. Drain Current

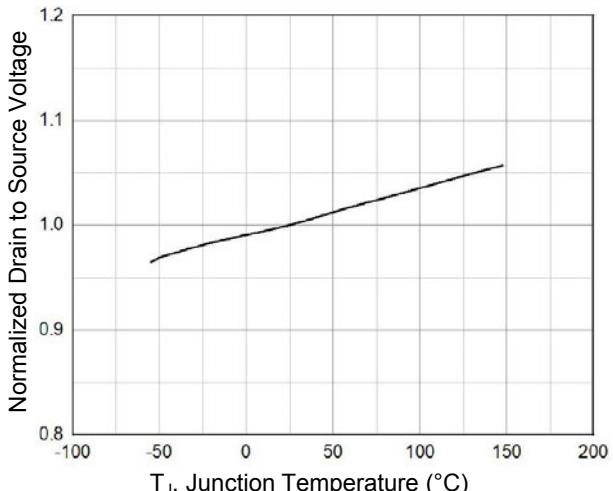


Figure 6. Normalized  $BV_{dss}$  vs. Junction Temperature

## Typical Electrical and Thermal Characteristic Curves

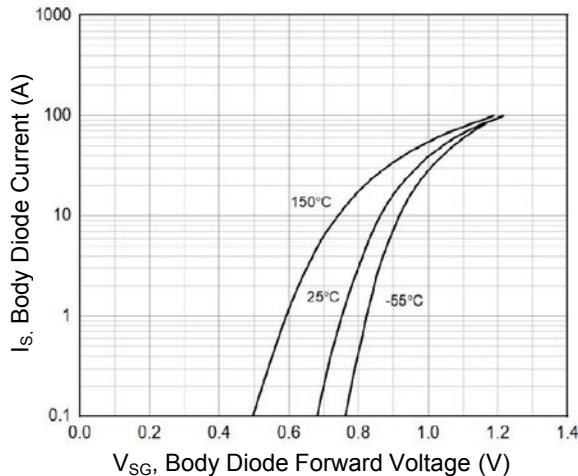


Figure 7. Body Diode Characteristics

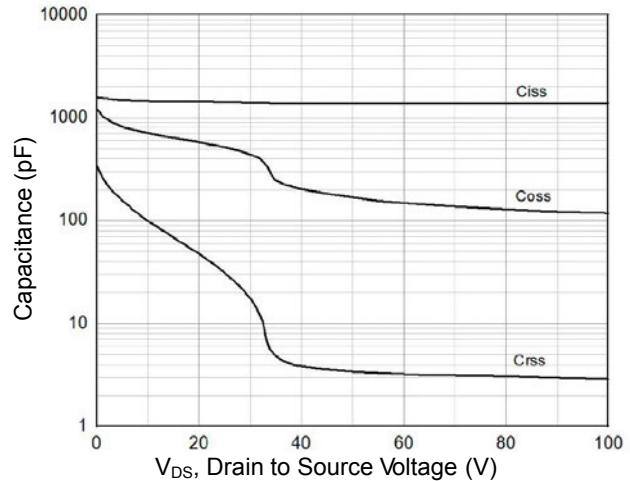


Figure 8. Capacitance Characteristics

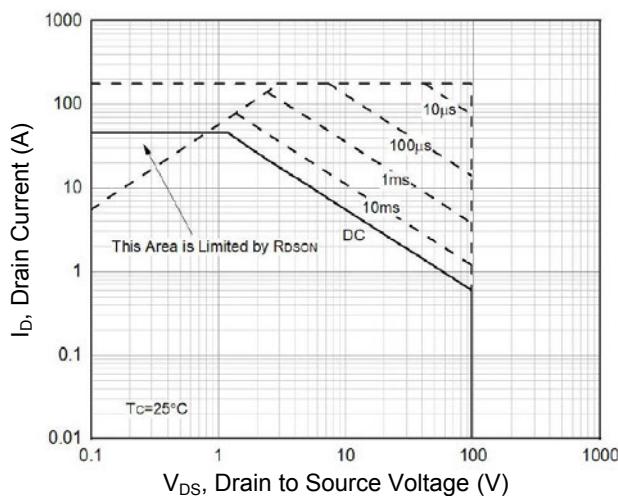
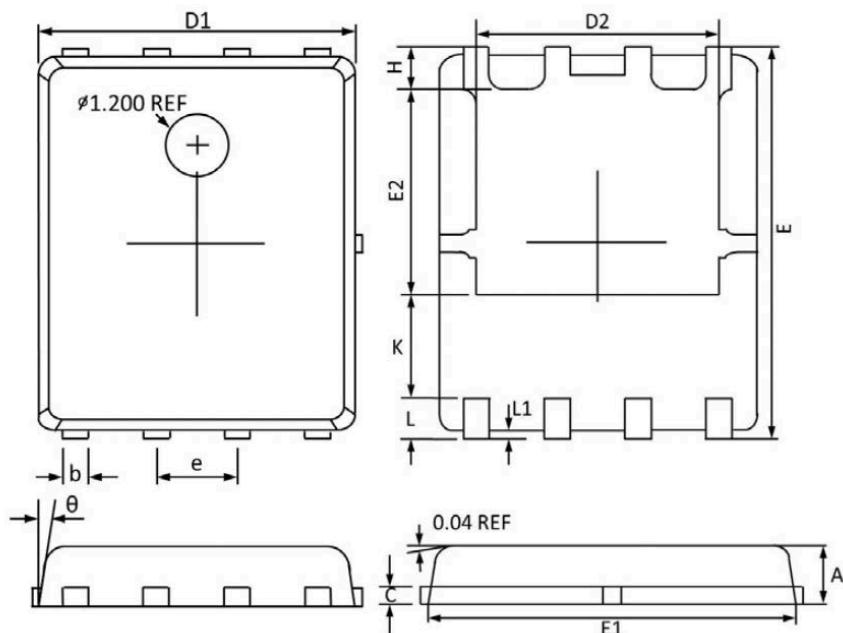


Figure 9. Safe Operation Area

### Package Outline Dimensions (PPAK5x6)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	0.800	1.100	0.031	0.043
b	0.330	0.510	0.013	0.020
C	0.200	0.300	0.008	0.012
D1	4.800	5.100	0.189	0.201
D2	3.610	4.100	0.142	0.161
E	5.900	6.200	0.232	0.244
E1	5.700	5.900	0.224	0.232
E2	3.350	3.780	0.132	0.149
e	1.27 BSC		0.05 BSC	
H	0.410	0.700	0.016	0.028
K	1.100	1.500	0.043	0.059
L	0.510	0.710	0.020	0.028
L1	0.060	0.200	0.002	0.008
Φ	0°	12°	0°	12°